# onsemi

### Linear Regulator -Dual-Rail, Very Low-Dropout, Programmable Soft-Start 1.5 A NCP59748

The NCP59748 is dual-rail very low dropout voltage regulator, capable of providing an output current in excess of 1.5 A with a dropout voltage of 60 mV typ. at full load current. The devices are stable with ceramic and any other type of output capacitor  $\geq 2.2 \,\mu\text{F}$ . This series contains adjustable output voltage version with output voltage down to 0.8 V. Internal protection features consist of built-in thermal shutdown and output current limiting protection. User-programmable Soft-Start and Power-Good pins are available on both QFN and DFN versions.

The NCP59748 is offered in DFN10 3×3 and QFN20 5×5 packages.

#### Features

- Output Current in Excess of 1.5 A
- V<sub>IN</sub> Range: 0.8 V to 5.5 V
- V<sub>BIAS</sub> Range: 2.7 V to 5.5 V
- Output Voltage Range: 0.8 V to 3.6 V
- Dropout Voltage: 60 mV at 1.5 A
- Programmable Soft-Start
- Open Drain Power Good Output
- Fast Transient Response
- Stable with Any Type of Output Capacitor  $\ge 2.2 \,\mu\text{F}$
- Current Limit and Thermal Shutdown Protection
- These are Pb-Free Devices

#### Applications

- Consumer and Industrial Equipment Point of Load Regulation
- FPGA, DSP and Logic Power Supplies
- Switching Power Supply Post Regulation

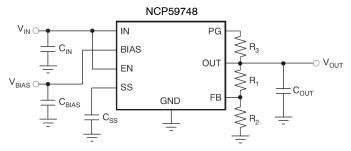


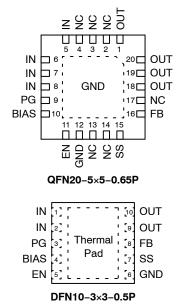
Figure 1. Typical Application Schematic



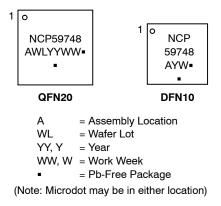


DFN10 CASE 485C

### PIN CONNECTIONS

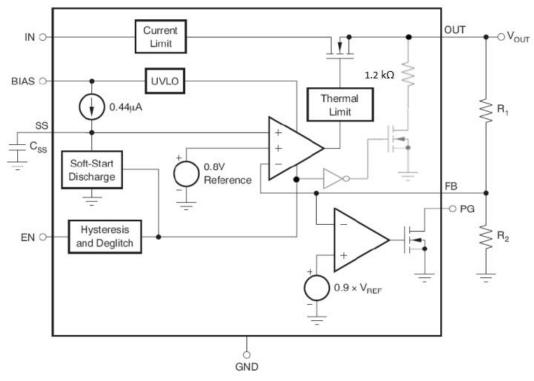


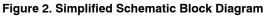




#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information on page 4 of this data sheet.





#### Table 1. PIN FUNCTION DESCRIPTION

Name	QFN20	DFN10	Description
IN	5–8	1, 2	Unregulated input to the device.
EN	11	5	Enable pin. Driving this pin high enables the regulator. Driving this pin low puts the regulator into shutdown mode. This pin must not be left floating.
SS	15	7	Soft-Start pin. A capacitor connected on this pin to ground sets the start-up time. If this pin is left floating, the regulator output soft-start ramp time is typically 200 $\mu$ s.
BIAS	10	4	Bias input voltage for error amplifier, reference, and internal control circuits.
PG	9	3	Power-Good (PG) is an open-drain, active-high output that indicates the status of $V_{OUT}$ . When $V_{OUT}$ exceeds the PG trip threshold, the PG pin goes into a high-impedance state. When $V_{OUT}$ is below this threshold the pin is driven to a low-impedance state. A pull-up resistor from 10 k $\Omega$ to 1 M $\Omega$ should be connected from this pin to a supply up to 5.5 V. The supply can be higher than the input voltage. Alternatively, the PG pin can be left floating if output monitoring is not necessary.
FB	16	8	This pin is the feedback connection to the center tap of an external resistor divider network that sets the output voltage. This pin must not be left floating.
OUT	1, 18–20	9, 10	Regulated output voltage. A small capacitor (total typical capacitance $\ge$ 2.2 $\mu$ F, ceramic) is needed from this pin to ground to assure stability.
NC	2–4, 13, 14, 17	N/A	No connection. This pin can be left floating or connected to GND to allow better thermal contact to the top-side plane.
GND	12	6	Ground
PAD/TAB			Should be soldered to the ground plane for increased thermal performance.

#### Table 2. ABSOLUTE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Input Voltage Range	V <sub>IN</sub>	-0.3 to +6	V
Input Voltage Range	V <sub>BIAS</sub>	-0.3 to +6	V
Enable Voltage Range	V <sub>EN</sub>	-0.3 to +6	V
Power-Good Voltage Range	V <sub>PG</sub>	-0.3 to +6	V
PG Sink Current	I <sub>PG</sub>	0 to +1.5	mA
SS Pin Voltage Range	V <sub>SS</sub>	-0.3 to +6	V
Feedback Pin Voltage Range	V <sub>FB</sub>	-0.3 to +6	V
Output Voltage Range	V <sub>OUT</sub>	$-0.3$ to (V <sub>IN</sub> + 0.3) $\leq 6$	V
Maximum Output Current	lout	Internally Limited	
Output Short Circuit Duration		Indefinite	
Continuous Total Power Dissipation	PD	See Thermal Characteristics Table and Formula	
Maximum Junction Temperature	T <sub>JMAX</sub>	+150	°C
Storage Junction Temperature Range	T <sub>STG</sub>	–55 to +150	°C
ESD Capability, Human Body Model (Note 2)	ESD <sub>HBM</sub>	2000	V
ESD Capability, Machine Model (Note 2)	ESD <sub>MM</sub>	200	V

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Refer to ELECTRICAL CHARACTERISTIS and APPLICATION INFORMATION for Safe Operating Area.

2. This device series incorporates ESD protection and is tested by the following methods:

ESD Human Body Model tested per EIA/JESD22-A114

ESD Machine Model tested per EIA/JESD22-A115

Latch-up Current Maximum Rating tested per JEDEC standard: JESD78.

#### **Table 3. THERMAL CHARACTERISTICS**

Rating	Symbol	Value	Unit
Thermal Characteristics, QFN20, 5x5, 0.65P package			
Thermal Resistance, Junction-to-Ambient (Note 5)	R <sub>θJA</sub>	30.5	°C/W
Thermal Resistance, Junction-to-Case (bottom) (Note 6)	$R_{\theta JC}$	4.1	°C/W
Thermal Characteristics, DFN10, 3x3, 0.5P package			
Thermal Resistance, Junction-to-Ambient (Note 5)	R <sub>θJA</sub>	41.5	°C/W
Thermal Resistance, Junction-to-Case (bottom) (Note 6)	$R_{ ext{ heta}JC}$	6.6	°C/W

3. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

4. Thermal data are derived by thermal simulations based on methodology specified in the JEDEC JESD51 series standards. The following assumptions are used in the simulations:

This data was generated with only a single device at the center of a high-K (2s2p) board with 3 in x 3 in copper area which follows the JEDEC51.7 guidelines.

- QFN20: The exposed pad is connected to the PCB ground layer through a 4x4 thermal via array. Vias are 0.3 mm diameter, plated. Each of top and bottom copper layers has a dedicated pattern for 20% copper coverage.

– DFN10: The exposed pad is connected to the PCB ground layer through a 3x2 thermal via array. Vias are 0.3 mm diameter, plated. Each of top and bottom copper layers are assumed to have thermal conductivity representing 20% copper coverage.

 The junction-to-ambient thermal resistance under natural convection is obtained in a simulation on a high-K board, following the JEDEC51.7 guidelines with assumptions as above, in an environment described in JESD51–2a.

6. The junction-to-case (bottom) thermal resistance is obtained by simulating a cold plate test on the IC exposed pad. Test description can be found in the ANSI SEMI standard G30-88.

#### Table 4. RECOMMENDED OPERATING CONDITIONS (Note 7)

Rating	Symbol	Min	Max	Unit
Input Voltage	V <sub>IN</sub>	V <sub>OUT</sub> + V <sub>DO</sub>	5.5	V
Bias Voltage	V <sub>BIAS</sub>	2.7	5.5	V
Junction Temperature	TJ	-40	125	°C

Functional operation above the stresses listed in the Recommended Operating Ranges is not implied. Extended exposure to stresses beyond the Recommended Operating Ranges limits may affect device reliability.

7. Refer to ELECTRICAL CHARACTERISTICS and APPLICATION INFORMATION for Safe Operating Area.

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V <sub>IN</sub>	Input Voltage Range		V <sub>OUT</sub> + V <sub>DO</sub>	_	5.5	V
V <sub>BIAS</sub>	Bias Pin Voltage Range		2.7	_	5.5	V
UVLO	Undervoltage Lock-out	V <sub>BIAS</sub> Rising Hysteresis		1.6 0.4	_	V
V <sub>REF</sub>	Internal Reference (Adj.)	$T_J = +25^{\circ}C$	0.796	0.8	0.804	V
V <sub>OUT</sub>	Output Voltage Range	V <sub>IN</sub> = 5 V, I <sub>OUT</sub> = 1.5 A	V <sub>REF</sub>	_	3.6	V
	Accuracy (Note 1)	2.97 V < V <sub>BIAS</sub> < 5.5 V, 50 mA < I <sub>OUT</sub> < 1.5 A	-2	±0.5	+2	%
V <sub>OUT</sub> /V <sub>IN</sub>	Line Regulation	V <sub>OUT (NOM)</sub> + 0.3 < V <sub>IN</sub> < 5.5 V	-	0.03	_	%/V
V <sub>OUT</sub> /I <sub>OUT</sub>	Load Regulation	50 mA < I <sub>OUT</sub> < 1.5 A	-	0.09	-	%/A
V <sub>DO</sub>	V <sub>IN</sub> Dropout Voltage (Note 2)	$\begin{array}{l} I_{OUT} = 1.5 \text{ A}, \\ V_{BIAS} - V_{OUT \ (NOM)} \geq 3.25 \text{ V} \ (\text{Note 3}) \end{array}$	-	60	165	mV
	V <sub>BIAS</sub> Dropout Voltage (Note 2)	I <sub>OUT</sub> = 1.5 A, V <sub>IN</sub> = V <sub>BIAS</sub>	-	1.31	1.6	V
I <sub>CL</sub>	Current Limit	$V_{OUT} = 80\% \times V_{OUT (NOM)}$	2.0	_	5.5	Α
I <sub>BIAS</sub>	Bias Pin Current		-	1	2	mA
I <sub>SHDN</sub>	Shutdown Supply Current (I <sub>GND</sub> )	$V_{EN} \le 0.4 V$	-	1	50	μA
I <sub>FB</sub>	Feedback Pin Current		-1	0.15	1	μA
PSRR	Power-Supply Rejection (V <sub>IN</sub> to V <sub>OUT</sub> )	1 kHz, I <sub>OUT</sub> = 1.5 A, V <sub>IN</sub> = 1.8 V, V <sub>OUT</sub> = 1.5 V	-	60	_	dB
		300 kHz, $I_{OUT}$ = 1.5 A, $V_{IN}$ = 1.8 V, $V_{OUT}$ = 1.5 V	-	30	-	
	Power-Supply Rejection (V <sub>BIAS</sub> to V <sub>OUT</sub> )	1 kHz, lout = 1.5 A, V <sub>IN</sub> = 1.8 V, V <sub>OUT</sub> = 1.5 V	-	50	-	dB
		300 kHz, lout = 1.5 A, V <sub>IN</sub> = 1.8 V, V <sub>OUT</sub> = 1.5 V	-	30	-	
Noise	Output Noise Voltage	100 Hz to 100 kHz, I <sub>OUT</sub> = 1.5 A	-	$25  imes V_{OUT}$	-	μVrms
tSTRT	Minimum Startup Time	$R_{LOAD}$ for $I_{OUT}$ = 1.0 A, $C_{SS}$ = open	-	200	-	μs
I <sub>SS</sub>	Soft-Start Charging Current	V <sub>SS</sub> = 0.4 V	-	0.44	-	μA
V <sub>EN, HI</sub>	Enable Input High Level		1.1	_	5.5	V
V <sub>EN, LO</sub>	Enable Input Low Level		0	-	0.4	V
V <sub>EN, HYS</sub>	Enable Pin Hysteresis		-	50	-	mV
V <sub>EN, DG</sub>	Enable Pin Deglitch Time		-	20	-	μs
I <sub>EN</sub>	Enable Pin Current	V <sub>EN</sub> = 5 V	-	0.1	1	μA
V <sub>IT</sub>	PG Trip Threshold	V <sub>OUT</sub> Decreasing	85	90	94	%V <sub>OU</sub>
V <sub>HYS</sub>	PG Trip Hysteresis		-	3	-	%V <sub>OU</sub>
V <sub>PG, LO</sub>	PG Output Low Voltage	I <sub>PG</sub> = 1 mA (Sinking), V <sub>OUT</sub> < V <sub>IT</sub>	-	-	0.3	V
I <sub>PG, LKG</sub>	PG Leakage Current	$V_{PG}$ = 5.25 V, $V_{OUT}$ > $V_{IT}$	-	0.1	1	μA
TSD	Thermal Shutdown Temperature	Shutdown, Temperature Increasing Reset, Temperature Decreasing		+165 +140		°C

 $\begin{array}{l} \textbf{Table 5. ELECTRICAL CHARACTERISTICS} \text{ (At } V_{EN} = 1.1 \text{ V}, \text{ } V_{IN} = V_{OUT} + 0.3 \text{ V}, \text{ } C_{BIAS} = 0.1 \text{ } \mu\text{F}, \text{ } C_{SS} = 1 \text{ } n\text{F}, \text{ } C_{IN} = C_{OUT} = 10 \text{ } \mu\text{F}, \text{ } I_{OUT} = 50 \text{ } \text{m}\text{A}, \text{ } V_{BIAS} = 5.0 \text{ V}, \text{ } T_J = -40^{\circ}\text{C} \text{ to } +125^{\circ}\text{C}, \text{ unless otherwise noted. Typical values are at } T_J = +25^{\circ}\text{C}. \end{array}$ 

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

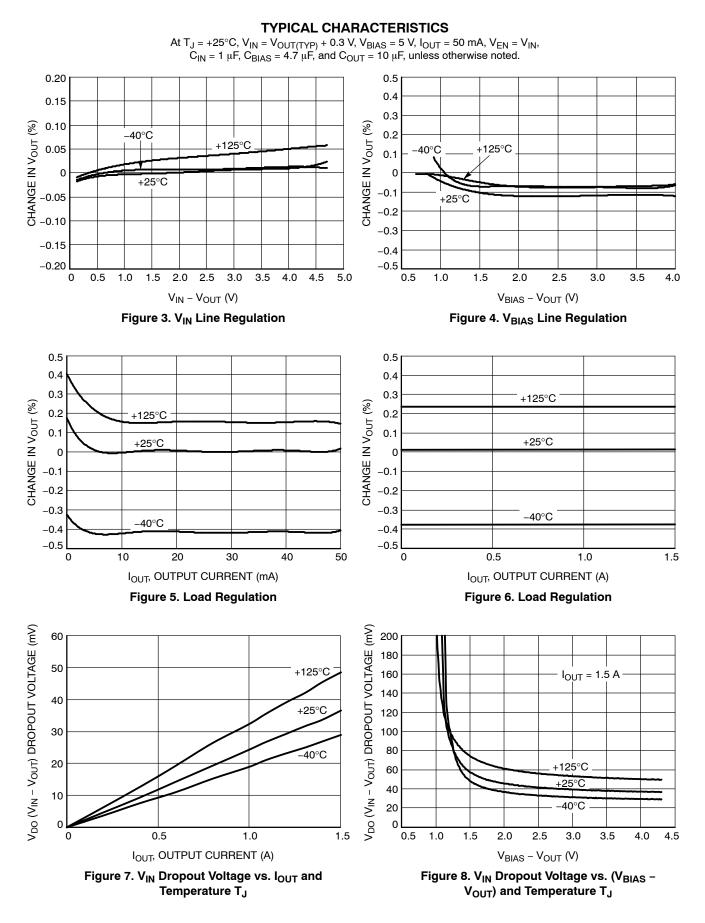
Adjustable devices tested at V<sub>REF</sub>; external resistor tolerance is not taken into account.
Dropout is defined as the voltage from the input to V<sub>OUT</sub> when V<sub>OUT</sub> is 3% below nominal.

3. 3.25 V is a test condition of this device and can be adjusted by referring to Figure 8.

#### **Table 6. ORDERING INFORMATION**

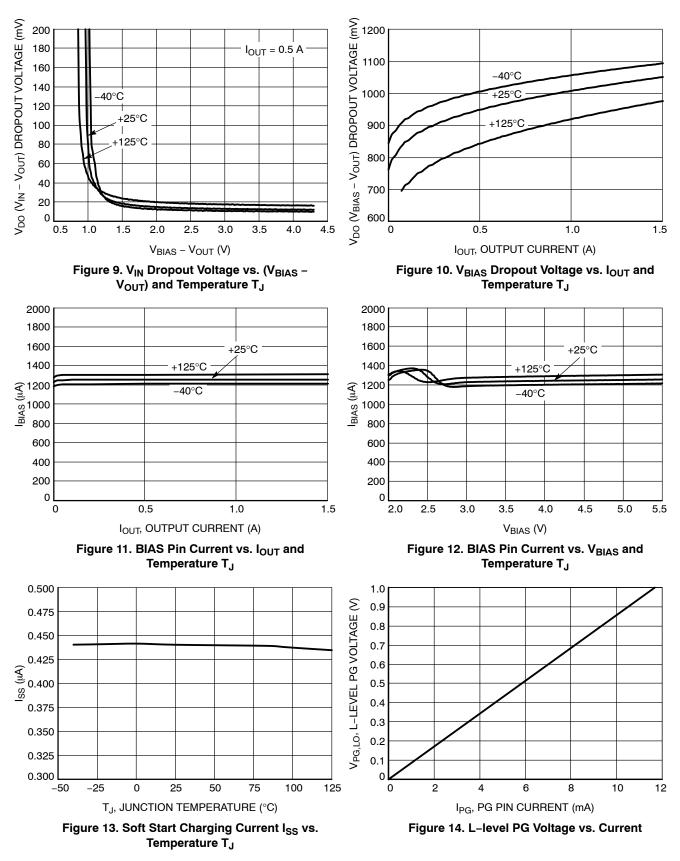
Device	Output Current	Output Voltage	Junction Temperature Range	Package	Shipping <sup>†</sup>
NCP59748MN1ADJTBG	1.5 A	ADJ	–40°C to +125°C	DFN10	3000 / Tape & Reel
NCP59748MN2ADJTBG	1.5 A	ADJ	–40°C to +125°C	QFN20	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



#### **TYPICAL CHARACTERISTICS**

At T<sub>J</sub> = +25°C, V<sub>IN</sub> = V<sub>OUT(TYP)</sub> + 0.3 V, V<sub>BIAS</sub> = 5 V, I<sub>OUT</sub> = 50 mA, V<sub>EN</sub> = V<sub>IN</sub>, C<sub>IN</sub> = 1  $\mu$ F, C<sub>BIAS</sub> = 4.7  $\mu$ F, and C<sub>OUT</sub> = 10  $\mu$ F, unless otherwise noted.



#### **TYPICAL CHARACTERISTICS**

At T<sub>J</sub> = +25°C, V<sub>IN</sub> = V<sub>OUT(TYP)</sub> + 0.3 V, V<sub>BIAS</sub> = 5 V, I<sub>OUT</sub> = 50 mA, V<sub>EN</sub> = V<sub>IN</sub>, C<sub>IN</sub> = 1  $\mu$ F, C<sub>BIAS</sub> = 4.7  $\mu$ F, and C<sub>OUT</sub> = 10  $\mu$ F, unless otherwise noted.

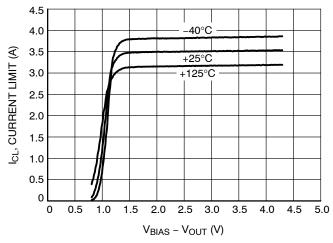


Figure 15. Current Limit vs. (V<sub>BIAS</sub> – V<sub>OUT</sub>)

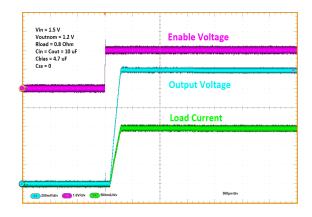


Figure 16. Start by Enable @ C<sub>SS</sub> = 0 nF

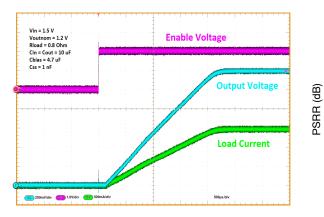
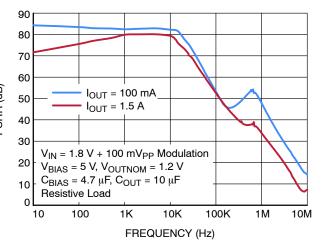
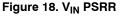
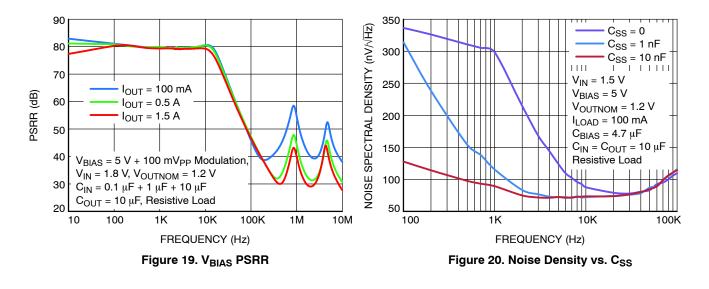


Figure 17. Start by Enable @ C<sub>SS</sub> = 1 nF







#### APPLICATIONS INFORMATION

The NCP59748 dual-rail very low dropout voltage regulator is using NMOS pass transistor for output voltage regulation from  $V_{IN}$  voltage. All the low current internal controll circuitry is powered from the  $V_{BIAS}$  voltage.

The use of an NMOS pass transistor offers several advantages in applications. Unlike a PMOS topology devices, the output capacitor has reduced impact on loop stability. Vin to Vout operating voltage difference can be very low compared with standard PMOS regulators in very low Vin applications.

The NCP59748 offers programmable smooth monotonic start-up. The controlled voltage rising limits the inrush current what is advantageous in applications with large capacitive loads. The Voltage Controlled Soft–Start timing is programmable by external Css capacitor value.

The Enable (EN) input is equipped with internal hysteresis and deglitch filter.

Open Drain type Power Good (PG) output is available for Vout monitoring and sequencing of other devices.

NCP58748 is a Adjustable linear regulator. The required Output voltage can be adjusted by two external resistors. Typical application schematics is shown in Figure 21.

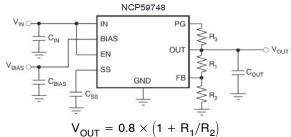


Figure 21. Typical Application Schematics

#### **Dropout Voltage**

Because of two power supply inputs  $V_{IN}$  and  $V_{BIAS}$  and one  $V_{OUT}$  regulator output, there are two Dropout voltages specified.

The first, the  $V_{IN}$  Dropout voltage is the voltage difference ( $V_{IN} - V_{OUT}$ ) when  $V_{OUT}$  starts to decrease by percents specified in the Electrical Characteristics table.  $V_{BIAS}$  is high enough, specific value is published in the Electrical Characteristics table.

The second,  $V_{BIAS}$  dropout voltage is the voltage difference ( $V_{BIAS} - V_{OUT}$ ) when  $V_{IN}$  and  $V_{BIAS}$  pins are joined together and  $V_{OUT}$  starts to decrease.

#### Input and Output Capacitors

The device is designed to be stable for all available types and values of output capacitors  $\geq 2.2 \,\mu\text{F}$ . The device is also stable with multiple capacitors in parallel, which can be of any type or value.

In applications where no low input supplies impedance available (PCB inductance in  $V_{IN}$  and/or  $V_{BIAS}$  inputs as example), the recommended  $C_{IN}$  and  $C_{BIAS}$  value is 1  $\mu$ F or

greater. Ceramic or other low ESR capacitors are recommended. For the best performance all the capacitors should be connected to the NCP59748 respective pins directly in the device PCB copper layer, not through vias having not negligible impedance.

#### Enable Operation

The enable pin will turn the regulator on or off. The threshold limits are covered in the electrical characteristics table in this data sheet. If the enable function is not to be used then the pin should be connected to  $V_{IN}$  or  $V_{BIAS}$ .

The NCP59748 device is equipped with Output Active Discharge transistor that is pulling the output to GND through an  $1.2 \text{ k}\Omega$  (typ.) resistor when the device is disabled.

To get the full functionality of Soft–Start, it is recommended to turn on the  $V_{IN}$  and  $V_{BIAS}$  supply voltages first and activate the Enable pin no sooner than  $V_{IN}$  and  $V_{BIAS}$  are on their nominal levels.

#### **Output Noise**

When the NCP59748 device reaches the end of the Soft–Start cycle, the Soft Start capacitor is switched to serve as a Noise filtering capacitor.

#### Output Voltage Adjust

The output voltage can be adjusted from 0.8 V to 3.6 V using resistors divider between the output and the FB input. Recommended resistor values for frequently used voltages can be found in the Table 7.

#### Programmable Soft-Start

The Soft-Start ramp time depends on the Soft–Start charging current  $I_{SS}$ , Soft-Start capacitor value  $C_{SS}$  and internal reference voltage  $V_{REF}$ .

The Soft–Start time can be calculated using following equations:

 $t_{ss} = C_{SS} x (V_{REF} / I_{SS}) [s, F, V, A]$ 

or in more practical units

 $t_{SS} = C_{SS} \ge 0.8 V / 0.44 = C_{SS} \ge 1.82$ 

where

t<sub>ss</sub> = Soft-Start time in miliseconds

 $C_{SS}$  = Soft-Start capacitor value in nano Farads

Capacitor values for frequently used Soft-Start times can be found in the Table 8.

The maximal recommended value of  $C_{SS}$  capacitor is 15 nF. For higher  $C_{SS}$  values the capacitor full discharging before new Soft-Start cycle is not guaranteed.

#### **Power Good**

Power–Good (PG) is an open–drain, active–high output that indicates the status of  $V_{OUT}$ . When  $V_{OUT}$  exceeds the PG trip threshold, the PG pin goes into a high–impedance state. When  $V_{OUT}$  is below this threshold the pin is driven to a low–impedance state. A pull–up resistor from 10 k $\Omega$  to

1 M $\Omega$  should be connected from this pin to a supply up to 5.5 V. The supply can be higher than the input voltage. Alternatively, the PG pin can be left floating if output monitoring is not necessary.

#### **Current Limitation**

The internal Current Limitation circuitry allows the device to supply the full nominal current and surges but protects the device against Current Overload or Short. The response time of this protection is in the range of microseconds.

#### **Thermal Protection**

Internal thermal shutdown (TSD) circuitry is provided to protect the integrated circuit in the event that the maximum junction temperature is exceeded. When TSD activated, the regulator output turns off. When cooling down under the low temperature threshold, device output is activated again. This TSD feature is provided to prevent failures from accidental overheating.

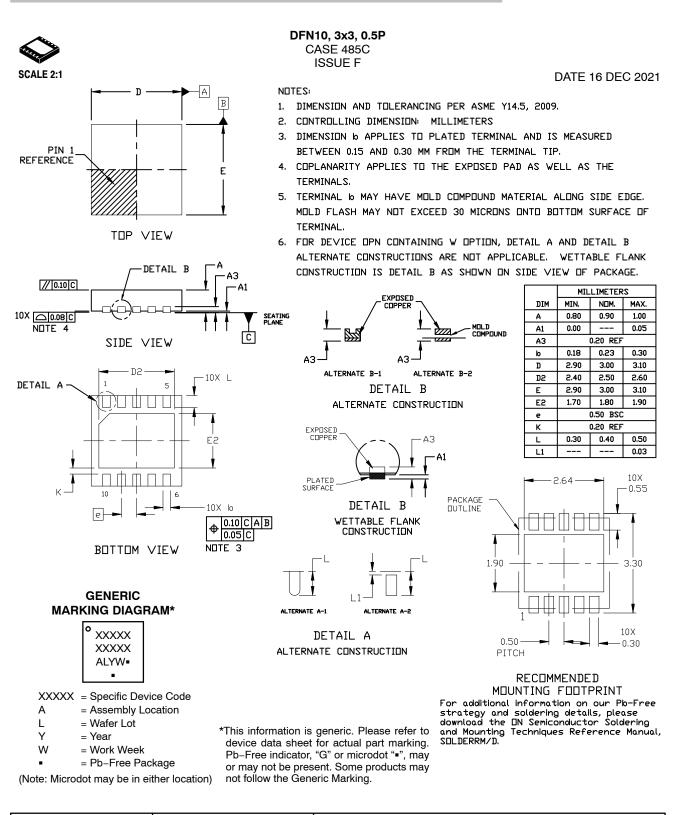
Table 7. RESISTOR VALUES FOR PROGRAMMING
THE OUTPUT VOLTAGE

V <sub>OUT</sub> (V)	R <sub>1</sub> (kΩ)	R <sub>2</sub> (kΩ)
0.8	Short	Open
0.9	0.619	4.99
1.0	1.13	4.53
1.05	1.37	4.33
1.1	1.87	4.99
1.2	2.49	4.99
1.5	4.12	4.75
1.8	3.57	2.87
2.5	3.57	1.69
3.3	3.57	1.15

NOTE:  $V_{OUT} = 0.8 \times (1 + R_1/R_2)$ Resistors in the table are standard 1% types

## Table 8. CAPACITOR VALUES FOR PROGRAMMING THE SOFT-START TIME

Soft-Start Time	C <sub>SS</sub>
0.2 ms	Open
0.5 ms	270 pF
1 ms	560 pF
5 ms	2.7 nF
10 ms	5.6 nF
18 ms	10 nF



DOCUMENT NUMBER:	98AON03161D	Electronic versions are uncontrolled except when accessed directly from the Document Repose Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in red.			
DESCRIPTION:	DESCRIPTION: DFN10, 3X3 MM, 0.5 MM PITCH		PAGE 1 OF 1		
onsemi and ONSEMi. are trademarks of Semiconductor Components Industries, LLC dba onsemi or its subsidiaries in the United States and/or other countries. onsemi reserves the right to make changes without further notice to any products herein. onsemi makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does onsemi assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation					

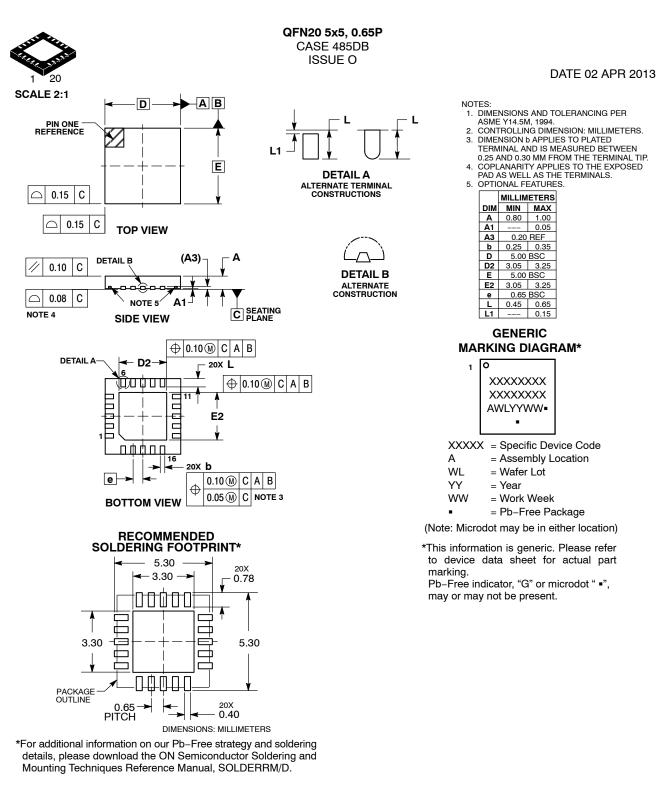
special, consequential or incidental damages. onsemi does not convey any license under its patent rights nor the rights of others.

© Semiconductor Components Industries, LLC, 2019

DUSEM

#### MECHANICAL CASE OUTLINE PACKAGE DIMENSIONS





DOCUMENT NUMBER:	98AON88183E Electronic versions are uncontrolled except when accessed directly from the Docu Printed versions are uncontrolled except when stamped "CONTROLLED COPY" in					
DESCRIPTION:	QFN20 5x5, 0.65P		PAGE 1 OF 1			
ON Semiconductor and (III) are trac	ON Semiconductor and 🕅 are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries.					

ON Semiconductor reasons the index of semiconductor components industries, LCD due do Semiconductor on its subsidiaries in the United States and/or one common of United States and/or one common of United States and/or one common set on the subsidiaries in the United States and/or one common of United States and/or one common set on the subsidiaries in the United States and/or one common set on the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries in the United States and/or one common set one of the subsidiaries of the subsidiaries and the United States and/or one common set one of the subsidiaries of the s

onsemi, ONSEMI, and other names, marks, and brands are registered and/or common law trademarks of Semiconductor Components Industries, LLC dba "onsemi" or its affiliates and/or subsidiaries in the United States and/or other countries. onsemi owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of onsemi's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. onsemi reserves the right to make changes at any time to any products or information herein, without notice. The information herein is provided "as-is" and onsemi makes no warranty, representation or guarantee regarding the accuracy of the information, product features, availability, functionality, or suitability of its products for any particular purpose, nor does **onsemi** assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using **onsemi** products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by **onsemi**. "Typical" parameters which may be provided in **onsemi** data sheets and/or specifications can and do vary in different applications and calcular performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. **onsemi** does not convey any license under any of its intellectual property rights nor the rights of others. **onsemi** products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use **onsemi** products for any such unintended or unauthorized application, Buyer shall indemnify and hold **onsemi** and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that **onsemi** was negligent regarding the design or manufacture of the part. **onsemi** is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

#### PUBLICATION ORDERING INFORMATION

#### LITERATURE FULFILLMENT:

#### TECHNICAL SUPPORT

onsemi Website: www.onsemi.com

Email Requests to: orderlit@onsemi.com

North American Technical Support: Voice Mail: 1 800-282-9855 Toll Free USA/Canada Phone: 011 421 33 790 2910

Europe, Middle East and Africa Technical Support: Phone: 00421 33 790 2910 For additional information, please contact your local Sales Representative